



Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-075002	Application No. 10/728,903
	Applicant Akira Ishikawa		
	Filing Date December 8, 2003	Group Art Unit 2826	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
TE	AA	5,166,556	11/24/1992	Hsu et al.	_____	_____	01/22/1991
	AB	5,206,749	04/27/1993	Zavracky et al.	_____	_____	12/31/1990
	AC	5,256,562	10/26/1993	Vu et al.	_____	_____	11/04/1992
	AD	5,258,325	11/02/1993	Spitzer et al.	_____	_____	02/13/1992
	AE	5,317,236	05/31/1994	Zavracky et al.	_____	_____	12/31/1991
	AF	5,331,149	07/19/1994	Spitzer et al.	_____	_____	12/04/1992
	AG	5,376,561	12/27/1994	Vu et al.	_____	_____	04/24/1992
	AH	5,376,979	12/27/1994	Zavracky et al.	_____	_____	08/13/1993
	AI	5,396,304	03/07/1995	Salerno et al.	_____	_____	02/10/1993
	AJ	5,444,557	08/22/1995	Spitzer et al.	_____	_____	09/11/1992
	AK	5,467,154	11/14/1995	Gale et al.	_____	_____	02/10/1993
	AL	5,475,514	12/12/1995	Salerno et al.	_____	_____	08/11/1994
	AM	5,581,385	12/03/1996	Spitzer et al.	_____	_____	03/24/1995
	AN	5,661,371	08/26/1997	Salerno et al.	_____	_____	03/04/1996
	AO	5,666,175	09/09/1997	Spitzer et al.	_____	_____	08/29/1994
	AP	5,692,820	12/02/1997	Gale et al.	_____	_____	01/27/1995
	AQ	5,743,614	04/28/1998	Salerno et al.	_____	_____	06/07/1995
	AR	5,751,261	05/12/1998	Zavracky et al.	_____	_____	08/13/1993
	AS	5,861,929	01/19/1999	Spitzer	_____	_____	11/04/1992
	AT	6,022,792	02/08/2000	Ishii et al.	_____	_____	03/12/1997
	AU	6,043,800	03/28/2000	Spitzer et al.	_____	_____	06/06/1995
	AV	6,072,445	06/06/2000	Spitzer et al.	_____	_____	06/07/1995
	AW	6,320,568 B1	11/20/2001	Zavracky	_____	_____	12/27/1994
TE	AX	6,424,020 B1	07/23/2002	Vu et al.	_____	_____	12/29/1997

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No

Examiner Signature 	Date Considered 8/15/05
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	Applicant Akira Ishikawa		
	Filing Date December 8, 2003	Group Art Unit 2826	

Foreign Patent Documents or Published Foreign Patent Applications								
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							Yes	No
	AY							
	AZ							
	AAA							
	ABB							
	ACC							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
TG	ADD	Australian Patent Office Communication – Search Report (Singapore Patent Application No. 200105539-1) dated September 30, 2004; 4 pages
	AEE	
	AFF	
	AGG	

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		Applicant Akira Ishikawa	
	Filing Date December 3, 2003	Group Art Unit 1826	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<u>TD</u>	AA	5,376,561	12/27/1994	Vu et al.	_____	_____	04/24/1992
	AB	5,643,826	07/01/1997	Ohtani et al.	_____	_____	10/25/1994
	AC	5,757,456	05/26/1998	Yamazaki et al.	_____	_____	03/08/1996
	AD	5,766,977	06/16/1998	Yamazaki	_____	_____	03/27/1996
	AE	5,834,327	11/10/1998	Yamazaki et al.	_____	_____	03/18/1996
	AF	6,127,199	10/03/2000	Inoue et al.	_____	_____	07/10/1998
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	AH	6,258,623	07/10/2001	Moden et al.	_____	_____	07/08/1999
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	AJ	6,022,792	02/2000	Ishii et al.	29	_____	
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	AL	5,757,456	05/26/1998	Yamazaki et al.	_____	_____	03/08/1996
<u>TD</u>	AM	5,953,595	09/14/1999	Gosain et al.	_____	_____	09/27/1996

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	AT	_____

Examiner Signature <u>[Signature]</u>	Date Considered <u>8/15/05</u>
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